







SN74ACT245-Q1 SCAS971 - MARCH 2024

# SN74ACT245-Q1 Automotive Octal Bus Transceivers With 3-State Outputs

### 1 Features

- AEC-Q100 qualified for automotive applications:
  - Device temperature grade 1: -40°C to +125°C
  - Device HBM ESD classification level 2
  - Device CDM ESD classification level C4B
- Available in wettable flank QFN package
- Operating voltage range of 4.5V to 5.5V
- TTL-compatible inputs
- Continuous ±24mA output drive at 5V
- Supports up to ±75mA output drive at 5V in short bursts
- Drives 50Ω transmission lines
- Fast operation with delay of 10ns max ( $V_{CC} = 5V$ ,  $C_1 = 50pF$

## 2 Applications

- Drive an indicator LED
- Redrive a digital signal
- Drive a transmission line
- Hold a signal during controller reset

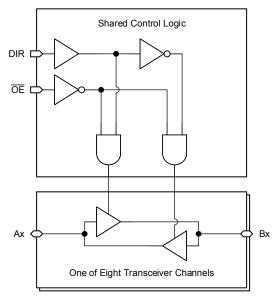
## 3 Description

The SN74ACT245-Q1 contains eight independent logic transceivers with shared output enable (OE) and direction control (DIR).

#### **Package Information**

_				
PART NUMBER		PACKAGE (1)	PACKAGE SIZE (2)	BODY SIZE (3)
		RKS (VQFN, 20)	4.5mm × 2.5mm	4.5mm × 2.5mm
s	N74ACT245-Q1	PW (TSSOP, 20)	6.5mm × 6.4mm	6.5mm × 4.4mm
		DGS (VSSOP, 20)	5.1mm × 4.9mm	5.1mm × 3mm

- For more information, see Section 11.
- The package size (length × width) is a nominal value and includes pins, where applicable
- The body size (length × width) is a nominal value and does not include pins.



Logic Diagram (Positive Logic)



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# **4 Pin Configuration and Functions**

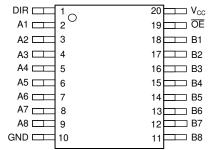


Figure 4-1. DGS and PW Package, 20-Pin VSSOP and TSSOP (Top View)

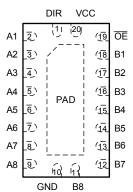


Figure 4-2. RKS Package, 20-Pin VQFN (Top View)

**Table 4-1. Pin Functions** 

PIN		TYPE <sup>(1)</sup>	DESCRIPTION	
NAME	NO.	ITPE	DESCRIPTION	
DIR	1	I	Direction control input (L = B $\rightarrow$ A, H = A $\rightarrow$ B)	
A1	2	I/O	Channel 1 output/input A	
A2	3	I/O	Channel 2 output/input A	
A3	4	I/O	Channel 3 output/input A	
A4	5	I/O	Channel 4 output/input A	
A5	6	I/O	Channel 5 output/input A	
A6	7	I/O	Channel 6 output/input A	
A7	8	I/O	Channel 7 output/input A	
A8	9	I/O	Channel 8 output/input A	
GND	10	G	Ground	
B8	11	I/O	Channel 8 input/output B	
B7	12	I/O	Channel 7 input/output B	
B6	13	I/O	Channel 6 input/output B	
B5	14	I/O	Channel 5 input/output B	
B4	15	I/O	Channel 4 input/output B	
B3	16	I/O	Channel 3 input/output B	
B2	17	I/O	Channel 2 input/output B	
B1	18	I/O	Channel 1 input/output B	
ŌĒ	19	I	Output enable, active low	
V <sub>CC</sub>	20	Р	Positive supply	
Thermal pad <sup>()</sup>	2)	_	The thermal pad can be connected to GND or left floating. Do not connect to any other signal or supply	

- (1) I = input, O = output, I/O = input or output, G = ground, P = power.
- (2) RKS package only.

## **5 Specifications**

## 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

	· · ·		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
VI	Input voltage range <sup>(2)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
Vo	Output voltage range <sup>(2)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < -0.5V or V <sub>I</sub> > V <sub>CC</sub> + 0.5V		±20	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < -0.5V or V <sub>O</sub> > V <sub>CC</sub> + 0.5V		±50	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±50	mA
	Continuous output current through V <sub>CC</sub> or GND			±200	mA
TJ	Junction temperature			150	°C
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

## 5.2 ESD Ratings

			VALUE	UNIT
	Electrostatic	Human body model (HBM), per AEC Q100-002 HBM ESD Classification Level 2 <sup>(1)</sup>	±2000	
V <sub>(ESD)</sub>	discharge	Charged device model (CDM), per AEC Q100-011 CDM ESD Classification Level C4B	±1000	V

<sup>(1)</sup> AEC Q100-002 indicate that HBM stressing shall be in accordrance with the ANSI/ESDA/JEDEC JS-001 specification.

### **5.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

Spec	Description	Condition	MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	Supply voltage	4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	High-level input voltage	2		V
V <sub>IL</sub>	Low-Level input voltage	Low-Level input voltage		0.8	V
V <sub>I</sub>	Input Voltage	Input Voltage	0	V <sub>CC</sub>	V
Vo	Output Voltage	Output Voltage	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current	High-level output current		-24	mA
I <sub>OL</sub>	Low-level output current	Low-level output current		24	mA
Δt/Δν	Input transition rise or fall rate	Input transition rise or fall rate		20	ns/V
T <sub>A</sub>	Operating free-air temperature	Operating free-air temperature	-40	125	°C

## **5.4 Thermal Information**

THERMAL METRIC(1)		DGS (VSSOP)	PW (TSSOP)	RKS (VQFN)	UNIT
		20 PINS	20 PINS	20 PINS	UNII
$R_{\theta JA}$	Junction-to-ambient thermal resistance	123.5	126.2	66.5	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	62.1	68.7	68.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	78.5	77.3	40.1	°C/W

Product Folder Links: SN74ACT245-Q1

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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THERMAL METRIC(1)		DGS (VSSOP)	PW (TSSOP)	RKS (VQFN)	UNIT
		20 PINS	20 PINS	20 PINS	ONII
$\Psi_{JT}$	Junction-to-top characterization parameter	7.8	22.3	10.5	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	78	76.9	40.1	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	23.7	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

## **5.5 Electrical Characteristics**

over operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMPLETIONS		T <sub>A</sub>	= 25°C		-40°C	to 125°C		UNIT
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	MIN	TYP	MAX	
	I 50A	4.5V	4.4	4.49		4.4			
	I <sub>OH</sub> = -50μA	5.5V	5.4	5.49					
V	1 - 24mA	4.5V	3.86			3.7			V
V <sub>OH</sub>	I <sub>OH</sub> = -24mA	5.5V	4.86						V
	I <sub>OH</sub> = -50mA	5.5V				3.85			
	I <sub>OH</sub> = -75mA	5.5V				3.85			
	I - 50A	4.5V		0.001	0.1			0.1	
	I <sub>OH</sub> = 50μA	5.5V		0.001	0.1			0.1	V
V	I <sub>OH</sub> = 24mA	4.5V			0.36			0.5	
V <sub>OL</sub>		5.5V			0.36			0.5	
	I <sub>OH</sub> = 50mA	5.5V						1.65	
	I <sub>OH</sub> = 75mA	5.5V						1.65	
I <sub>I</sub>	V <sub>I</sub> = 5.5V or GND	0V to 5.5V			±0.1			±1	μΑ
I <sub>OZ</sub>	V <sub>O</sub> = V <sub>CC</sub> or GND	5.5V			±0.5			±10	μA
I <sub>CC</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5V			4			80	μA
ΔI <sub>CC</sub>	$V_I = V_{CC} - 2.1V$ ; Any Input	4.5V to 5.5V			0.6			1.5	mA
Cı	V <sub>I</sub> = V <sub>CC</sub> or GND	5V		9					pF
Co	V <sub>O</sub> = V <sub>CC</sub> or GND	5V		15					pF
C <sub>PD</sub>	C <sub>L</sub> = 50pF, F = 1MHz	5V		17					pF

## **5.6 Switching Characteristics**

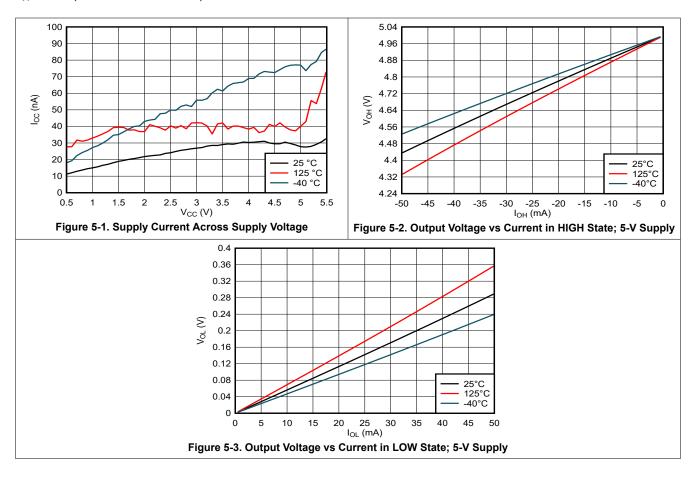
 $C_L$  = 50pF; over operating free-air temperature range; typical values measured at  $T_A$  = 25°C (unless otherwise noted). See Parameter Measurement Information

PARAME	RAME FROM (INPUT) TO (OUTPUT) V <sub>CC</sub>		V	T <sub>A</sub> = 25°C			-40°C to 125°C			UNIT
TER	FROM (INFOT)	10 (001701)	V <sub>cc</sub>	MIN	TYP	MAX	MIN	TYP	MAX	ONT
t <sub>pd</sub>	A or B	B or A	5 V	1	4	8	1		10	ns
t <sub>en</sub>	ŌĒ	A or B	5 V	1	5.5	10	1		13	ns
t <sub>dis</sub>	ŌĒ	A or B	5 V	1	5.5	10	1		12	ns
t <sub>sk(o)</sub>			5 V			1			1	ns



## **5.7 Typical Characteristics**

T<sub>A</sub> = 25°C (unless otherwise noted)

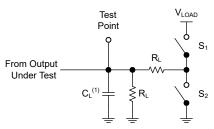


### **6 Parameter Measurement Information**

Phase relationships between waveforms were chosen arbitrarily for the examples listed in the following table. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1MHz,  $Z_O = 50\Omega$ ,  $t_t < 2.5$ ns,  $V_t = 1.5$ V.

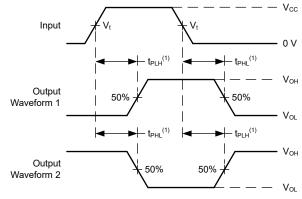
The outputs are measured individually with one input transition per measurement.

TEST	S1	S2	R <sub>L</sub>	CL	ΔV	V <sub>LOAD</sub>
t <sub>PLH</sub> , t <sub>PHL</sub>	OPEN	OPEN	500Ω	50pF	_	_
t <sub>PLZ</sub> , t <sub>PZL</sub>	CLOSED	OPEN	500Ω	50pF	0.3V	2×V <sub>CC</sub>
t <sub>PHZ</sub> , t <sub>PZH</sub>	OPEN	CLOSED	500Ω	50pF	0.3V	_



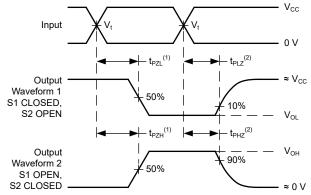
(1) C<sub>L</sub> includes probe and test-fixture capacitance.

Figure 6-1. Load Circuit for 3-State Outputs



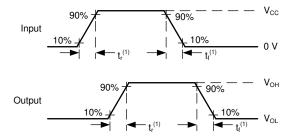
(1) The greater between  $t_{\text{PLH}}$  and  $t_{\text{PHL}}$  is the same as  $t_{\text{pd}}$ .

Figure 6-2. Voltage Waveforms Propagation Delays



- (1) The greater between t<sub>PZL</sub> and t<sub>PZH</sub> is the same as t<sub>en</sub>.
- (2) The greater between  $t_{\text{PLZ}}$  and  $t_{\text{PHZ}}$  is the same as  $t_{\text{dis}}.$

Figure 6-3. Voltage Waveforms Propagation Delays



(1) The greater between  $t_r$  and  $t_f$  is the same as  $t_t$ .

Figure 6-4. Voltage Waveforms, Input and Output Transition Times



## 7 Detailed Description

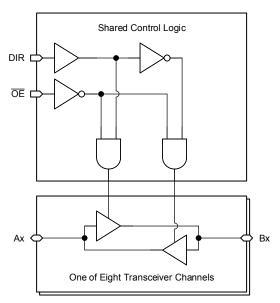
### 7.1 Overview

The SN74ACT245-Q1 is an octal bus transceiver with 3-state outputs. All eight channels are controlled by the direction (DIR) pin and output enable  $(\overline{OE})$  pin. Each transceiver includes one buffer oriented from Ax to Bx and one from Bx to Ax, with at least one output disabled at all times. The direction (DIR) pin controls which buffer is active. The buffer that is not active has the output placed into the high-impedance state.

The output enable  $(\overline{OE})$  controls all outputs in the device. When the  $\overline{OE}$  pin is in the low state, the appropriate outputs as determined by the direction (DIR) pin are enabled. When the  $\overline{OE}$  pin is in the high state, all outputs of the device are disabled. All disabled outputs are placed into the high-impedance state.

To put the device in the high-impedance state during power up or power down, tie  $\overline{OE}$  pin to  $V_{CC}$  through a pull-up resistor and drive the  $\overline{OE}$  pin low once the system is ready to begin normal operation. The current sinking capability of the driver and the leakage of the pin determines the minimum value of the resistor (as defined in the *Electrical Characteristics* table). Typically a  $10k\Omega$  resistor will be sufficient.

### 7.2 Functional Block Diagram



Logic Diagram (Positive Logic)

### 7.3 Feature Description

### 7.3.1 Balanced CMOS 3-State Outputs

This device includes balanced CMOS 3-state outputs. Driving high, driving low, and high impedance are the three states that these outputs can be in. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device can drive larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

When placed into the high-impedance state, the output will neither source nor sink current, with the exception of minor leakage current as defined in the *Electrical Characteristics* table. In the high-impedance state, the output voltage is not controlled by the device and is dependent on external factors. If no other drivers are connected to the node, then this is known as a floating node and the voltage is unknown. A pull-up or pull-down resistor can be connected to the output to provide a known voltage at the output while it is in the high-impedance state.

Product Folder Links: SN74ACT245-Q1

The value of the resistor will depend on multiple factors, including parasitic capacitance and power consumption limitations. Typically, a  $10k\Omega$  resistor can be used to meet these requirements.

Unused 3-state CMOS outputs should be left disconnected.

## 7.3.2 TTL-Compatible CMOS Inputs

This device includes TTL-compatible CMOS inputs. These inputs are specifically designed to interface with TTL logic devices by having a reduced input voltage threshold.

TTL-compatible CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using Ohm's law ( $R = V \div I$ ).

TTL-compatible CMOS inputs require that input signals transition between valid logic states quickly, as defined by the input transition time or rate in the *Recommended Operating Conditions* table. Failing to meet this specification will result in excessive power consumption and could cause oscillations. More details can be found in the *Implications of Slow or Floating CMOS Inputs* application report.

Do not leave TTL-compatible CMOS inputs floating at any time during operation. Unused inputs must be terminated at  $V_{CC}$  or GND. If a system will not be actively driving an input at all times, a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value will depend on multiple factors; however, a  $10k\Omega$  resistor is recommended and typically will meet all requirements.

#### 7.3.3 Wettable Flanks

This device includes wettable flanks for at least one package. See the *Features* section on the front page of the data sheet where packages include this feature.

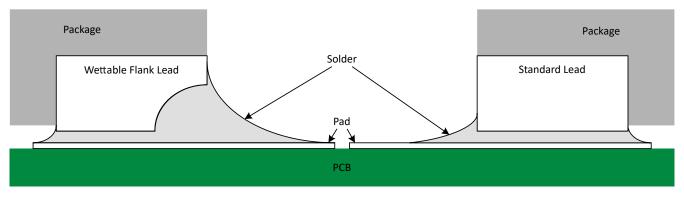


Figure 7-1. Simplified Cutaway View of Wettable-Flank QFN Package and Standard QFN Package After Soldering

Wettable flanks help improve side wetting after soldering, which makes QFN packages easier to inspect with automatic optical inspection (AOI). As shown in Figure 7-1, a wettable flank can be dimpled or step-cut to provide additional surface area for solder adhesion which assists in reliably creating a side fillet. See the mechanical drawing for additional details.

## 7.3.4 Clamp Diode Structure

As shown in Figure 7-2, the inputs and outputs to this device have both positive and negative clamping diodes.

#### CAUTION

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

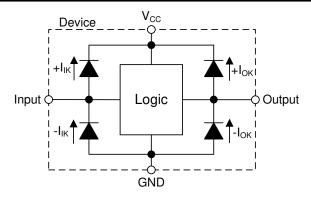


Figure 7-2. Electrical Placement of Clamping Diodes for Each Input and Output

## 7.4 Device Functional Modes

Table 7-1 lists the functional modes of the SN74ACT245-Q1.

**Table 7-1. Function Table** 

INPU	TS <sup>(1)</sup>	OUTPUTS (2)		
ŌĒ DIR		Α	В	
L	L	В	Z	
L	Н	Z	Α	
Н	Х	Z	Z	

- (1) H = High voltage level, L = Low voltage level, X = Don't care
- (2) A = Logic value at 'A' input, B = Logic value at 'B' input, Z = High impedance

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## 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 8.1 Application Information

The SN74ACT245-Q1 can be used to drive signals over relatively long traces or transmission lines. To reduce ringing caused by impedance mismatches between the driver, transmission line, and receiver, a series damping resistor placed in series with the transmitter's output can be used. The figure in the *Application Curve* section shows the received signal with three separate resistor values. Just a small amount of resistance can make a significant impact on signal integrity in this type of application.

### 8.2 Typical Application

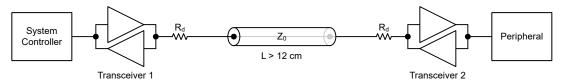


Figure 8-1. Typical Application Schematic

### 8.3 Design Requirements

#### 8.3.1 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the device's electrical characteristics as described in the *Electrical Characteristics* section.

The positive voltage supply must be capable of sourcing current equal to the total current to be sourced by all outputs of the SN74ACT245-Q1 plus the maximum static supply current,  $I_{CC}$ , listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only source as much current that is provided by the positive supply source. Be sure to not exceed the maximum total current through  $V_{CC}$  listed in the *Absolute Maximum Ratings*.

The ground must be capable of sinking current equal to the total current to be sunk, by all outputs of the SN74ACT245-Q1 plus the maximum supply current,  $I_{CC}$ , listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only sink as much current that can be sunk into its ground connection. Be sure to not exceed the maximum total current through GND listed in the *Absolute Maximum Ratings*.

The SN74ACT245-Q1 can drive a load with a total capacitance less than or equal to 50pF while still meeting all of the data sheet specifications. Larger capacitive loads can be applied; however, it is not recommended to exceed 50pF.

The SN74ACT245-Q1 can drive a load with total resistance described by  $R_L \ge V_O$  /  $I_O$ , with the output voltage and current defined in the *Electrical Characteristics* table with  $V_{OH}$  and  $V_{OL}$ . When outputting in the HIGH state, the output voltage in the equation is defined as the difference between the measured output voltage and the supply voltage at the  $V_{CC}$  pin.

Total power consumption can be calculated using the information provided in *CMOS Power Consumption and Cpd Calculation*.

Thermal increase can be calculated using the information provided in *Thermal Characteristics of Standard Linear* and Logic (SLL) Packages and Devices.



#### **CAUTION**

The maximum junction temperature,  $T_{J(max)}$  listed in the *Absolute Maximum Ratings*, is an additional limitation to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

### 8.3.2 Input Considerations

Input signals must cross  $V_{IL(max)}$  to be considered a logic LOW, and  $V_{IH(min)}$  to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either  $V_{CC}$  or ground. The unused inputs can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input will be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The drive current of the controller, leakage current into the SN74ACT245-Q1 (as specified in the *Electrical Characteristics*), and the desired input transition rate limits the resistor size. A  $10k\Omega$  resistor value is often used due to these factors.

The SN74ACT245-Q1 has CMOS inputs and thus requires fast input transitions to operate correctly, as defined in the *Recommended Operating Conditions* table. Slow input transitions can cause oscillations, additional power consumption, and reduction in device reliability.

Refer to the Feature Description section for additional information regarding the inputs for this device.

### 8.3.3 Output Considerations

The positive supply voltage is used to produce the output HIGH voltage. Drawing current from the output will decrease the output voltage as specified by the  $V_{OH}$  specification in the *Electrical Characteristics*. The ground voltage is used to produce the output LOW voltage. Sinking current into the output will increase the output voltage as specified by the  $V_{OL}$  specification in the *Electrical Characteristics*.

Push-pull outputs that could be in opposite states, even for a very short time period, should never be connected directly together. This can cause excessive current and damage to the device.

Two channels within the same device with the same input signals can be connected in parallel for additional output drive strength.

Unused outputs can be left floating. Do not connect outputs directly to V<sub>CC</sub> or ground.

Refer to the Feature Description section for additional information regarding the outputs for this device.

#### 8.4 Detailed Design Procedure

- Add a decoupling capacitor from V<sub>CC</sub> to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V<sub>CC</sub> and GND pins. An example layout is shown in the *Layout* section.
- Ensure the capacitive load at the output is ≤ 50pF. This is not a hard limit; by design, however, it will
  optimize performance. This can be accomplished by providing short, appropriately sized traces from the
  SN74ACT245-Q1 to one or more of the receiving devices.
- 3. Ensure the resistive load at the output is larger than  $(V_{CC} / I_{O(max)})\Omega$ . Doing this will prevent the maximum output current from the *Absolute Maximum Ratings* from being violated. Most CMOS inputs have a resistive load measured in M $\Omega$ ; much larger than the minimum calculated previously.
- 4. Thermal issues are rarely a concern for logic gates; the power consumption and thermal increase, however, can be calculated using the steps provided in the application report, *CMOS Power Consumption and Cpd Calculation*.

Product Folder Links: SN74ACT245-Q1

### 8.5 Application Curves

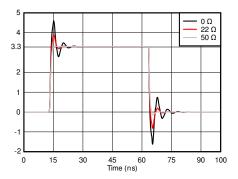


Figure 8-2. Simulated Signal Integrity at the Receiver With Different Damping Resistor (R<sub>d</sub>) Values

### 8.6 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. A  $0.1\mu F$  capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The  $0.1\mu F$  and  $1\mu F$  capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in the following layout example.

### 8.7 Layout

## 8.7.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices, inputs must never be left floating. In many cases, functions or parts of functions of digital logic devices are unused (for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used). Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or VCC, whichever makes more sense for the logic function or is more convenient.



### 8.7.2 Layout Example

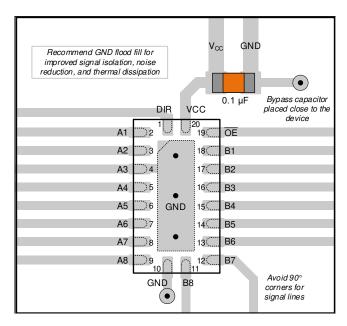


Figure 8-3. Example Layout for the SN74ACT245-Q1

## 9 Device and Documentation Support

### 9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

## 9.2 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 9.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

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## 9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 9.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

## 10 Revision History

DATE	REVISION	NOTES
March 2024	*	Initial Release

Product Folder Links: SN74ACT245-Q1



# 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: SN74ACT245-Q1

www.ti.com 27-Mar-2024

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
SN74ACT245DGSRQ1	ACTIVE	VSSOP	DGS	20	5000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	T245Q	Samples
SN74ACT245PWRQ1	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	T245Q	Samples
SN74ACT245WRKSRQ1	ACTIVE	VQFN	RKS	20	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	CT245WQ	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE OPTION ADDENDUM**

www.ti.com 27-Mar-2024

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN74ACT245-Q1:

Catalog: SN74ACT245

Military: SN54ACT245

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

• Military - QML certified for Military and Defense Applications

# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ACT245DGSRQ1	VSSOP	DGS	20	5000	330.0	16.4	5.4	5.4	1.45	8.0	16.0	Q1
SN74ACT245PWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74ACT245WRKSRQ1	VQFN	RKS	20	3000	180.0	12.4	2.8	4.8	1.2	4.0	12.0	Q1

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## \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ACT245DGSRQ1	VSSOP	DGS	20	5000	353.0	353.0	32.0
SN74ACT245PWRQ1	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74ACT245WRKSRQ1	VQFN	RKS	20	3000	210.0	185.0	35.0



SMALL OUTLINE PACKAGE



### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

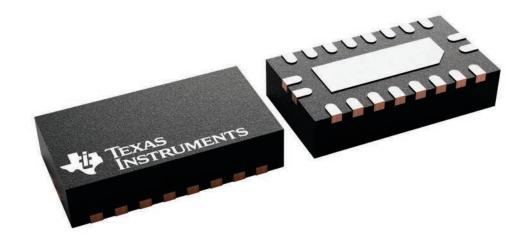
- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



2.5 x 4.5, 0.5 mm pitch

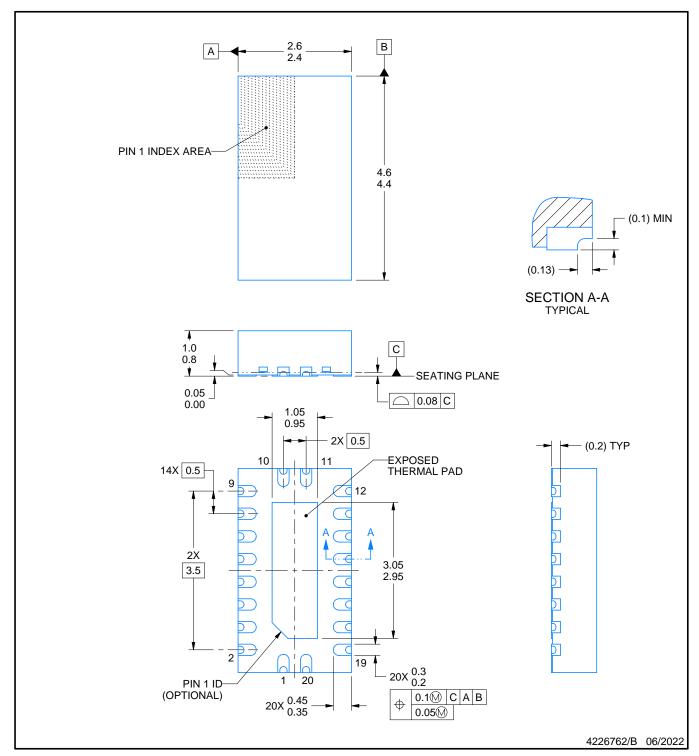
PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





PLASTIC QUAD FLATPACK - NO LEAD



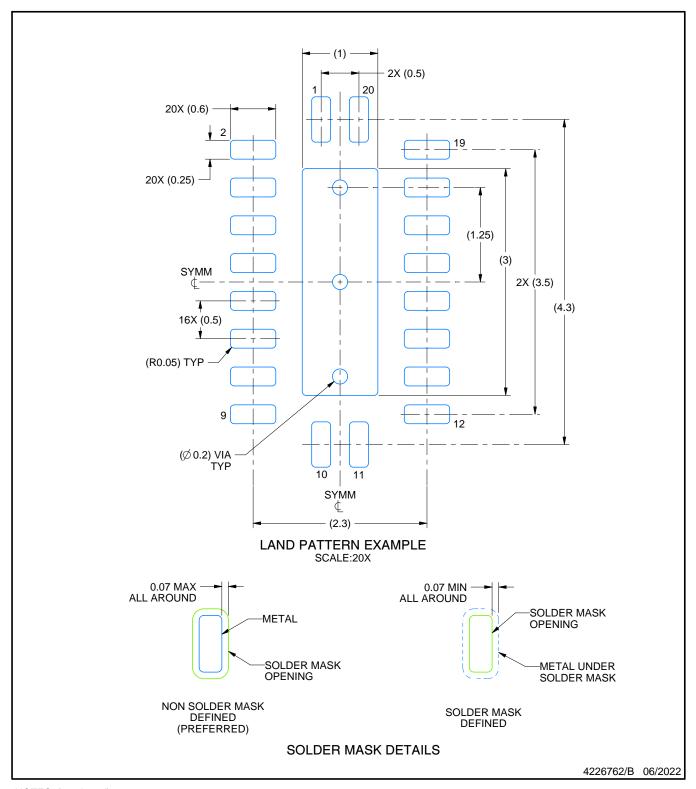
### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD

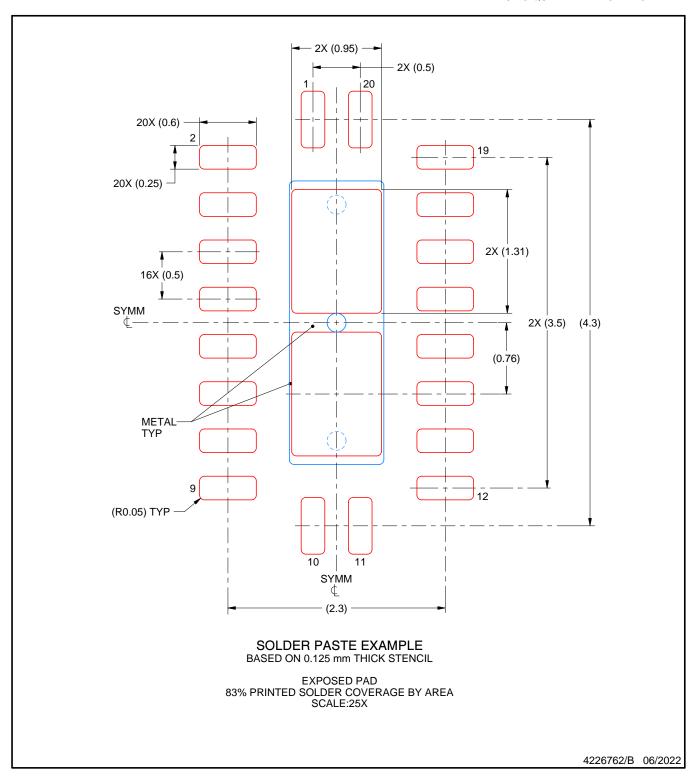


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If some or all are implemented, recommended via locations are shown.



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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